

By clicking "Accept All Cookies", you agree to the storing of cookies on your device to enhance navigation, offer personalized content, and analyze site usage. [Cookie Policy](#)

[Cookie Settings](#)

Accept All Cookies

Excessive Background Noise in GC

This Information Applies To: *Agilent GC Systems*

Issue

Excessive baseline noise can be introduced at different points including sample preparation, sample introduction, separation, and the detector. The excessive background can cause reduced signal-to-noise (detection limit), creating inaccurate quantitative or qualitative results.

Other chromatographic problems are identified in [Basic Troubleshooting for GC Systems](#). Regular maintenance of your instrument in accordance with the recommended maintenance schedule will reduce the incidence of chromatography problems.

Background

Over time sample deposits can accumulate in the analytical pathway and slowly leach out during subsequent sample analyses ([Figure 1](#)). The background can be consistently high across the entire sample run, or vary with the temperature program, and can vary significantly when the instrument is run continuously and after sitting idle.

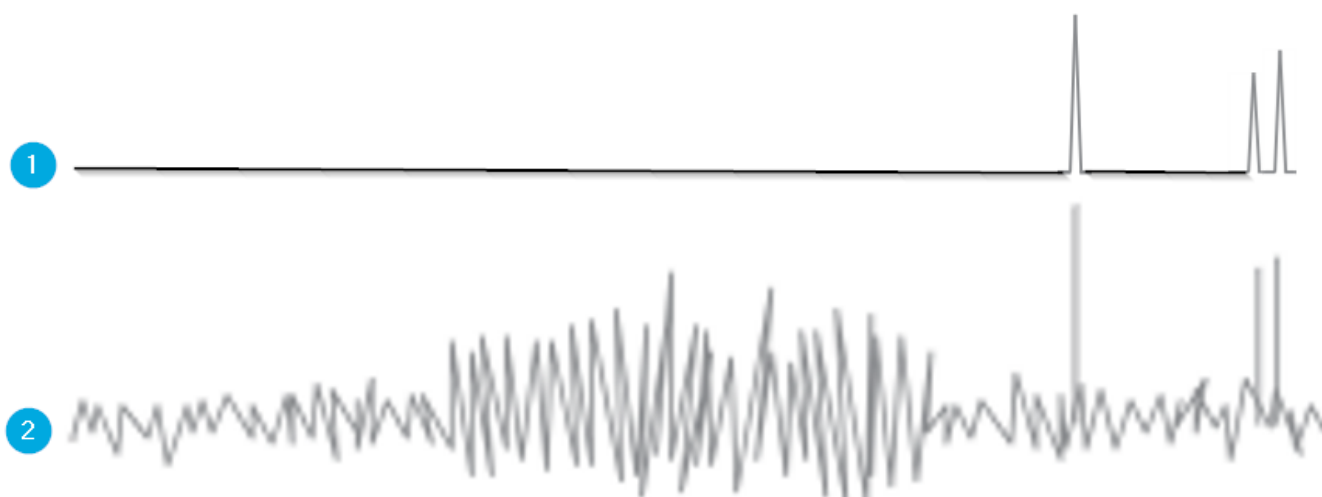


Figure 1. Excessive background noise

1. Normal background with peaks visible, 2. Excessive background with peaks partially obscured

Resolution

By clicking "Accept All Cookies", you agree to the storing of cookies on your device to enhance navigation, offer personalized content, and analyze site usage. [Cookie Policy](#)

[Cookie Settings](#)

Accept All Cookies

Possible source of background noise	Solution
Low quality or contaminated solvent	Check to see if the problems coincided with a change in solvent supply. If they did, change to a known contamination free solvent supply
Matrix effects from sample	Sample or extract clean up before the analysis
Sample contaminated during preparation (including contamination of solvent)	Check sample handling steps. Repeat sample preparation as necessary

2. Sample introduction system

Perform the [GC Condensation Test](#) to determine if the sample introduction system is the source of the contamination.


Possible source of contamination	Solution
Low quality or contaminated gas supply	Check to see if the problems coincided with a change in gas cylinder. If they did, change the gas cylinder and flush the gas lines for sufficient time to clear the volume of the gas system
Contaminated gas filter	Check the gas filter indicator (if available). If not, replace as per the maintenance schedule or after using contaminated gas
Septum bleed or degradation	Replace the septum. Use an Agilent high-quality septum appropriate for your inlet temperature. See Replacing the Inlet Septum for Split/Spitless and Multimode Inlets
Inlet liner dirty	Replace the inlet liner. Use an Agilent inlet liner appropriate for your injection volume, solvent, and injection mode
Gold seal is dirty	Replace the gold seal. See How to replace the Gold Seal on the Split/Spitless (SSL) Inlet for an Agilent GC
Inlet is contaminated	Clean or bake out the inlet. See How to Bake-out the Split/Spitless Inlet (SSL) on Agilent GC Systems

3. Analytical column

By clicking “Accept All Cookies”, you agree to the storing of cookies on your device to enhance navigation, offer personalized content, and analyze site usage. [Cookie Policy](#)

[Cookie Settings](#)


Accept All Cookies

Column contamination	 Caution: Do not exceed the manufacturer recommended maximum column temperate limit as it will damage your column. Trim the column: Remove 0.5 to 1 m from the front of the column
Column inserted too far/ not far enough into the detector	Remove and reinstall the column. See Capillary Column Installation Quick Reference Guide

4. Detector

Possible source of contamination	Solution
Detector contamination	Typically detector contamination increases over time and not suddenly. Clean the detector
Incorrect detector flow rates	Check that the flow rates are within recommended specifications
Detector leak (for MS, ECD, TCD)	Leak test the detector
Old detector filament, lamp, electron multiplier, or ion source	Review instrument logs. Clean or replace affected components

If these procedures have not resolved the excessive baseline noise, contact Agilent Technical Support.

 Learn how to effectively troubleshoot your Agilent GC System: [GC-0GEN-1040z - Practical Steps in GC Troubleshooting](#) e-learning course available from Agilent education

Was this helpful?

Still Need Assistance?

Contact Support

Ask the Community

By clicking "Accept All Cookies", you agree to the storing of cookies on your device to enhance navigation, offer personalized content, and analyze site usage. [Cookie Policy](#)

[Cookie Settings](#)

Accept All Cookies